

Date Searched: 12/14/2003

Databases Searched: USPAT, USPGPUB

Plurals: ON

Terms Searched:

L1 (symmetr\$6 near5 (area or window or partition\$3)) and ((defect\$3 or fault or bad) same (deviat\$4 or tolerance or threshold or thresh-hold or range) same symmetr\$6) and @pd>20030711

Results: 5 hits

Date Searched: 7/11/2003

Databases Searched: USPAT, USPGPUB

Plurals: ON

Terms Searched:

L1 716/\$.ccls. or 703/1,2.ccls. or 382/141-152,154,190-206.ccls.

L2 symmetr\$6 near5 (area or window or partition\$3)

L3 (defect\$3 or fault or bad) same (deviat\$4 or tolerance or threshold or thresh-hold or range) same symmetr\$6

L4 1 and 2 and 3

Results: 1 hit

L5 2 and 3

Results: 16 hits

US 5345514 A USPAT Mahdavi, Yaghoub et al. 382/152

US 4579455 A USPAT Levy, Kenneth et al. 356/394

US 4559603 A USPAT Yoshikawa, Ryoichi 716/5

US 3972616 A USPAT Minami, Masana et al. 356/71

US 20030099022 A1 US-PGPUB Karin, Jacob et al. 359/201

US 6515913 B2 USPAT Kajigaya, Kazuhiko et al. 365/189.02

US 6498685 B1 USPAT Johnson, Kenneth C. 359/626

Databases Searched: EPO, JPO, IBM TDB, Derwent

Plurals: ON

Terms Searched:

L1 symmetr\$6 near5 (area or window or partition\$3)

L2 (defect\$3 or fault or bad) same (deviat\$4 or tolerance or threshold or thresh-hold or range) same symmetr\$6

L3 1 and 2

Results: 4 hits

JP 04311277 A JPO SHOJI, HIROYUKI

Database Searched: IEE/IEEE Xplore

Terms Searched: (symmetr* <near/5> (area or window or partition*)) and (defect* or fault or bad) and (deviat* or tolerance or threshold or thresh-hold or range) and symmetr*

Results: Your search matched 3 of 951805 documents.

Terms Searched: (area or window or partition*) and (defect* or fault or bad) and (deviat* or tolerance or threshold or thresh-hold or range) and symmetr*

Results: Your search matched 19 of 951805 documents.

Terms Searched: (defect* or fault or bad) and symmetr* and image

Results: Your search matched 14 of 951805 documents.